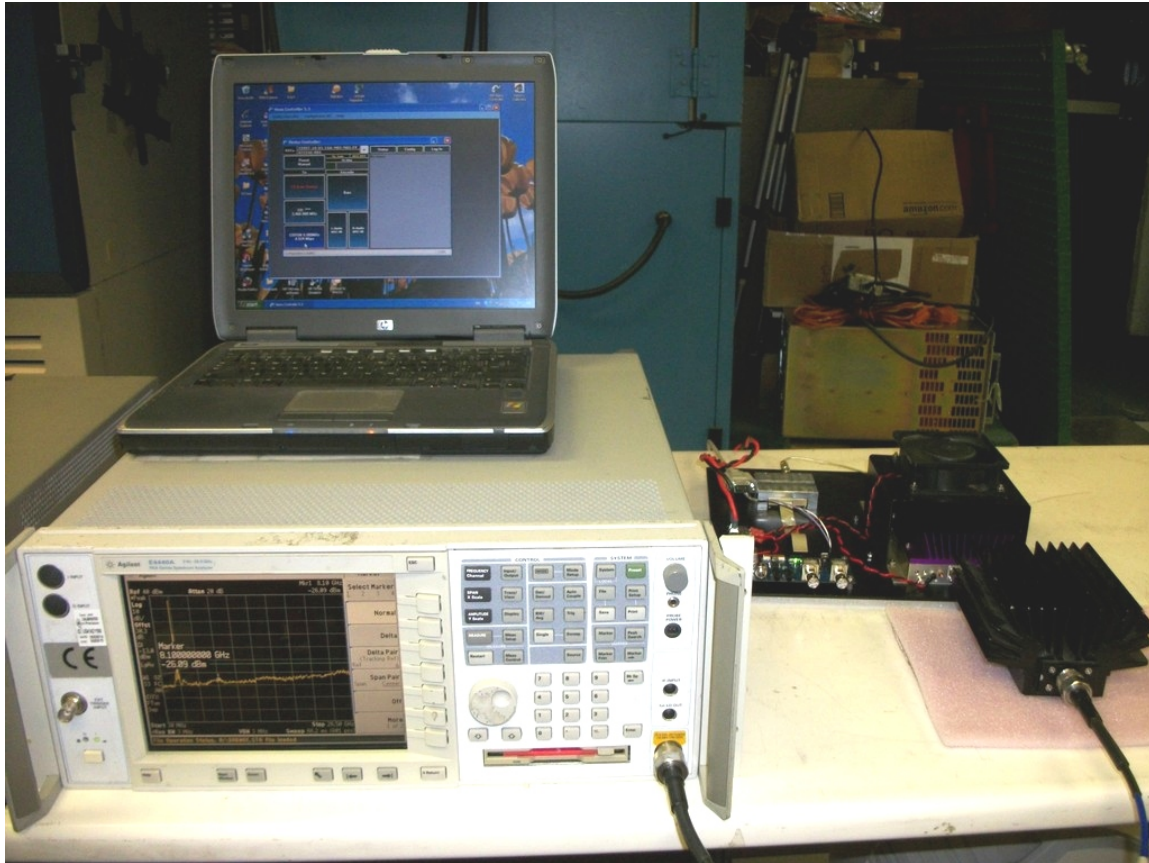


Section 12. Setup Photos

RF Output Power



Conducted Measurement (OC, Spurious)



Emission Limitation Mask



Field Strength of Spurious



Frequency Stability

